

<b>Notice of References Cited</b>	Application/Control No. 10/643,516	Applicant(s)/Patent Under Reexamination PAYNE, J. DAVID	
	Examiner Nghi V. Tran	Art Unit 2151	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,163,811	12-2000	Porter, Swain W.	709/247
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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